


Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. KM1-001	SERIAL NO. 09/652,550
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT: Keiji Jono et al.	
				FILING DATE August 31, 2000	



U.S. PATENT DOCUMENTS							
*Examiner's Initials	Class	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
qv	AA	5,915,191	06/1999	Jun	438	431	
qv	AB	6,087,705	07/2000	Gardner et al.	257	510	
qv	AC	6,355,540 B1	03/2002	Wu	438	433	
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FOREIGN PATENT DOCUMENTS								
*Examiner's Initials	Class	Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)		
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	AN	
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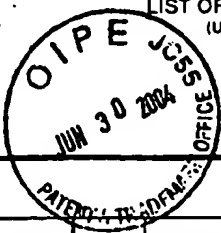
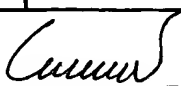
EXAMINER <i>Cum</i>	DATE CONSIDERED 09/10/04
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

EV372458831

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<div style="display: flex; align-items: center; justify-content: center;"> <div> <p>LIST OF ART CITED BY APPLICANT</p> <p>(Use several sheets if necessary)</p> </div> </div>				APPLICANT: Keiji Jono et al.			
				FILING DATE August 31, 2000		GROUP 2811	
U.S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
qv	AA	6,081,662	06/27/00	Murakami et al.			
qv	AB	5,994,198	11/30/99	Hsu et al.			
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U.S. PATENT DOCUMENTS							
*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
qv	AA 6,034,409	03/07/2000	Sakai et al.				
qv	AB 6,171,924 B1	01/09/2001	Wang et al.				
qv	AC 6,154,417	11/28/2000	Kim				
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